

Supporting information

Integration of Fe_xS Electrocatalysts and Simultaneously Generated Interfacial Oxygen Vacancies to Synergistically Boost Photoelectrochemical Water Splitting of Fe₂O₃ Photoanodes

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Experimental section

Synthesis of $Fe_2O_3/V_o/Fe_xS$ photoanode: Firstly, FeOOH nanorods were vertically aligned on the FTO substrate according to reported methods by our group.²¹ More details had been described previously. FeOOH and sulfur powder separately were placed at two heating zones of a pipe furnace. With increase of temperature of the furnace to 300 °C under argon atmosphere, sulfur powder sublimed into the gas phase (sulfur sublimation temperature of ~ 95 °C) and reacted with the surface of the FeOOH nanorod arrays for 30 min to generate a thin layer of Fe_xS . To grow the Fe_xS , the FeOOH nanorod arrays were placed 15 cm apart from the S powder (sulfur, AR, 99.9%), inside a quartz tube. With ~199 sccm of high-purity Ar gas as the carrier gas, the furnace temperature was raised to 300 °C. After 30 min of sulfuration, the furnace was allowed to cool to room temperature under the argon flow, followed by heating at 550 °C for 120 minutes in Ar gas, and subsequently at 650 °C for 15 min to result in the coating of Fe_xS on the Fe_2O_3 nanorod. As comparison, the pristine Fe_2O_3 nanorods were also synthesized under the same growth conditions without the sulfuration process.

Sample characterizations: A FEI NOVA NanoSEM230 scanning electron microscope was employed to investigate the morphology of samples. The crystal structure of samples was identified by X-ray diffraction (XRD) (Ultima III, Rigaku) with Cu Ka radiation ($k = 0.154$ nm). Transmission electron microscope (TEM) images were taken on a JEM 200CX TEM apparatus. X-ray photoelectron spectroscopy (XPS) was carried out on a Thermo Scientific K-Alpha instrument operating with an unmonochromatized Al Ka X-ray source, and the data were calibrated by the binding energy of the C1s line at 283.6 eV. A Shimadzu UV-2550 spectrometer equip with an integrating sphere was used to investigate the absorption properties of samples. Electrochemical impedance spectroscopic (EIS) curves were measured by a PAR2273 workstation (CHI-633E, Shanghai Chenhua) under a forward bias of 0.2 V and AM 1.5G illumination. The frequency ranged from 0.1 mHz to 100 kHz. The Mott-Schottky curves were measured in 1 M NaOH aqueous solution using an electrochemical analyzer (Princeton Applied Research, 2273). The surface photovoltage microscopy (SPVM) and conductive atomic force microscopy (C-AFM) measurements were performed by a commercial AFM

system (Bruker Dimension Icon) equipped with a 450-nm laser to excite the sample. The Bruker SCM-PIT probe was used for both SPVM and C-AFM mapping. For the SPVM mapping, the AM-KPFM mode was used and the SPVM images were obtained by direct subtraction between a steady-state illuminated and a dark KPFM scan at the same location. In the KPFM scan, the lift height of probe was set at 20 nm. For the C-AFM mapping, Peak Force TUNA mode was used. All scan parameters are optimized with respect to good signal-to-noise ratio.

Photoelectrochemical property measurements: The photoelectrochemical (PEC) performance of the photoanodes is investigated in a three-electrode cell using an electrochemical analyzer (CHI-630D, Shanghai Chenhua) under AM 1.5G illumination. The electrolyte is a 1 M NaOH aqueous solution (pH~13.6). The Fe₂O₃ sample is used as a working electrode. A Pt foil and a saturated Ag/AgCl electrode are used as a counter and a reference electrode. The RHE potential is calculated following the formula $V_{\text{RHE}} = V_{\text{Ag/AgCl}} + 0.059\text{pH} + E_{\text{Ag/AgCl}}$, where V_{RHE} is the converted potential versus RHE, and $E^{\circ}_{\text{Ag/AgCl}} = 0.1976 \text{ V}$ at 25 °C. The active area of the Fe₂O₃ sample is fixed to 0.28 cm² using a black mask. A cyclic voltammetry method is adopted with a scan rate of 10 mV s⁻¹.

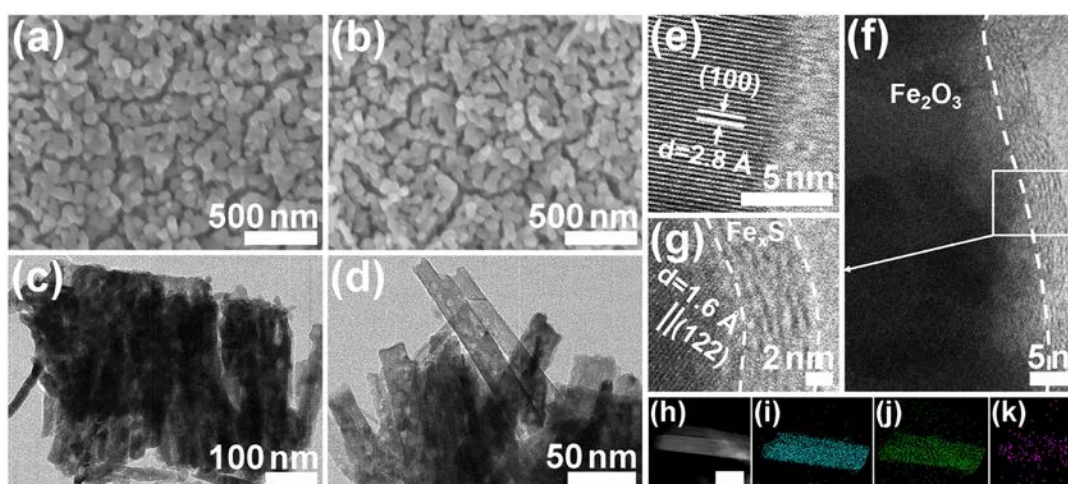


Fig. S1 (a, b) SEM images and (c, d) TEM images of Fe_2O_3 and $\text{Fe}_2\text{O}_3|\text{V}_o|\text{Fe}_x\text{S}$, respectively. (e) HRTEM images for Fe_2O_3 . (f) HRTEM images of $\text{Fe}_2\text{O}_3|\text{V}_o|\text{Fe}_x\text{S}$, (g) enlarged image of (f). (h-k) for the TEM and the corresponding EDS mapping images of O, Fe and S for $\text{Fe}_2\text{O}_3|\text{V}_o|\text{Fe}_x\text{S}$, respectively, the scale bar is 500 nm.

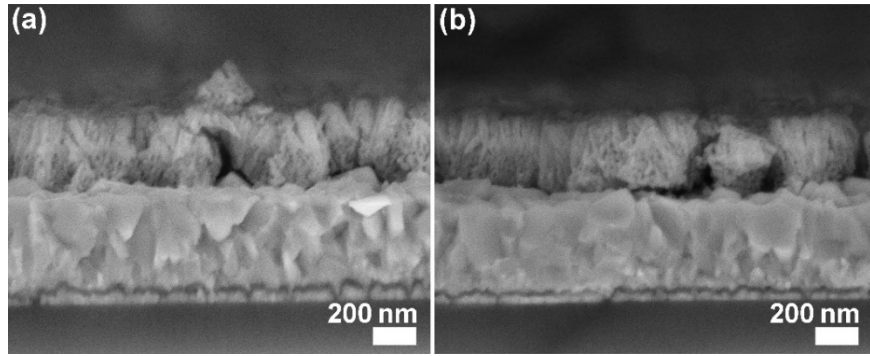


FIG. S2 (a) and (b) The cross-sectional views of Fe_2O_3 and $\text{Fe}_2\text{O}_3|\text{V}_0|\text{Fe}_x\text{S}$, respectively.

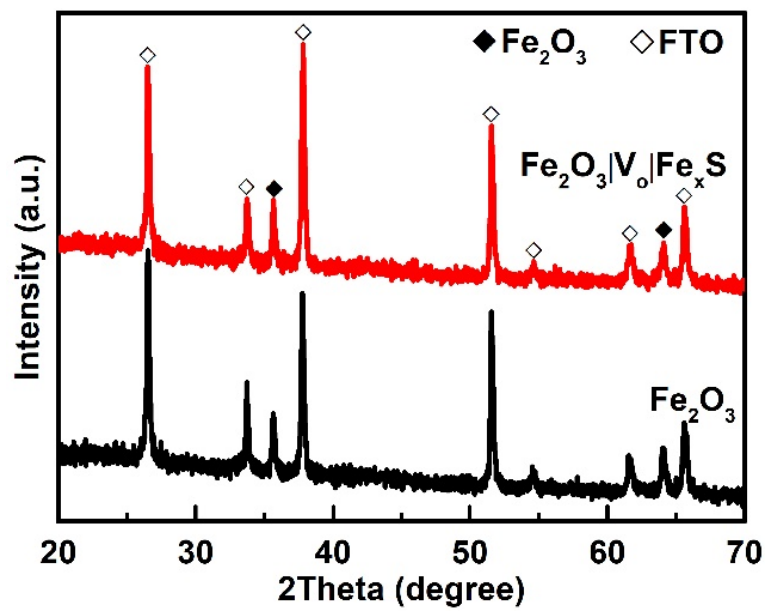


Fig. S3 XRD patterns of Fe_2O_3 and $\text{Fe}_2\text{O}_3|\text{V}_0|\text{Fe}_x\text{S}$.

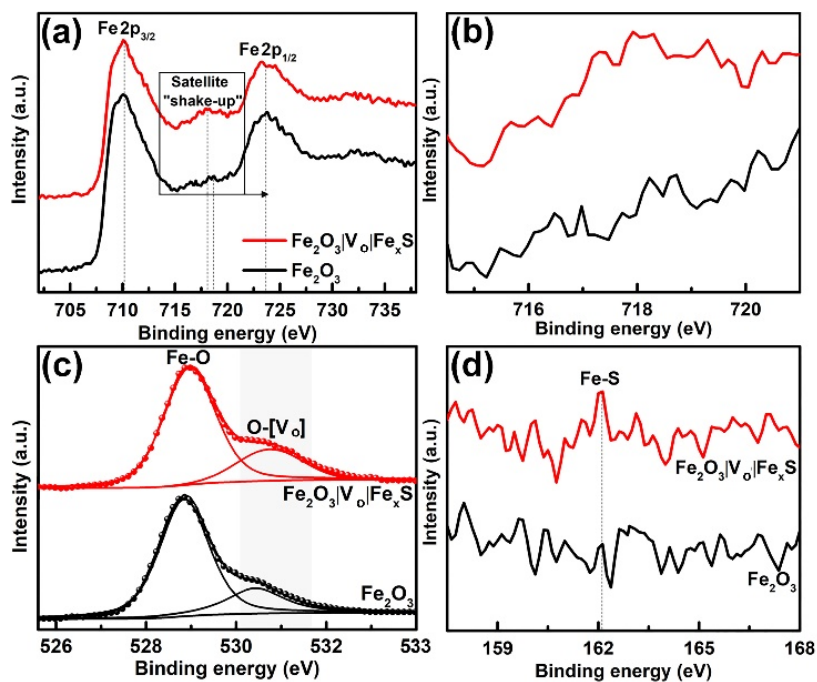


Fig. S4 XPS high resolution (a) Fe 2p, (b) enlarged image of (a), the Fe^{2+} signal peak is labelled with black circles. (c) O 1s, and (d) S 2p spectra of Fe_2O_3 and $\text{Fe}_2\text{O}_3|\text{V}_0|\text{Fe}_x\text{S}$.

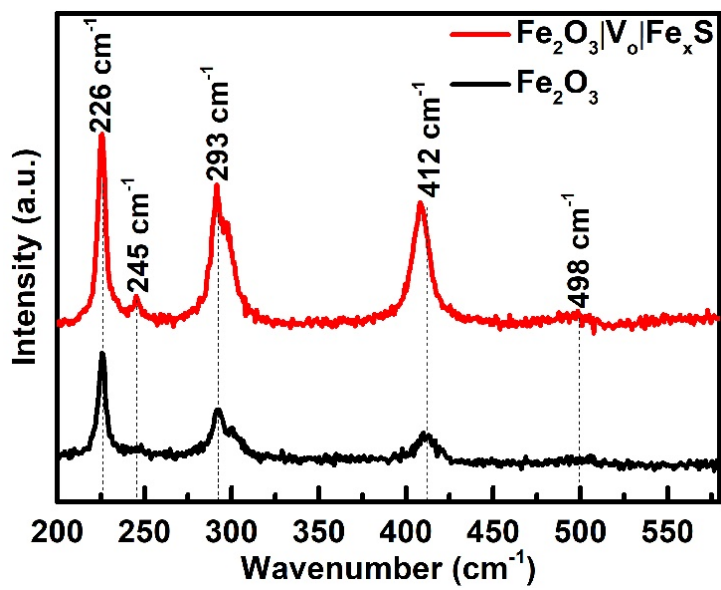


Fig. S5 Raman spectra of Fe₂O₃ and Fe₂O₃|V₀|Fe_xS.

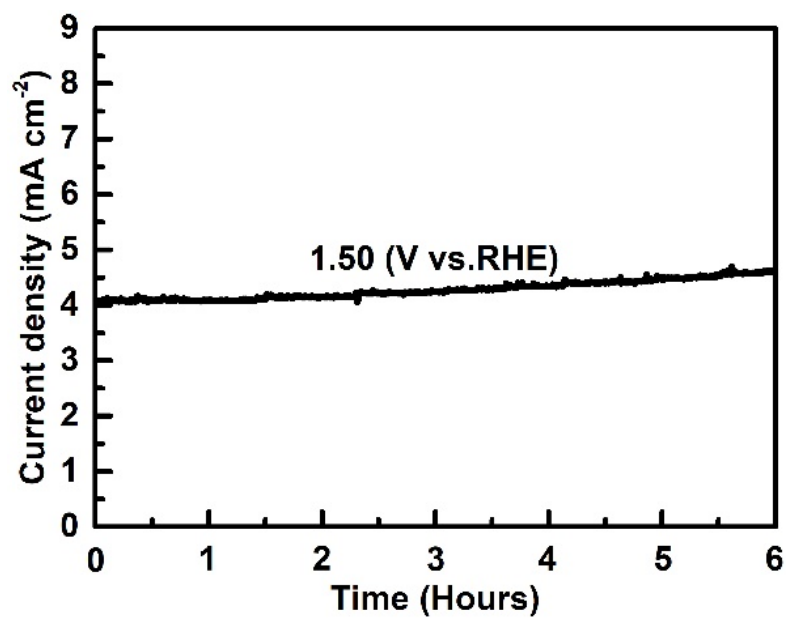


Fig. S6 Current density versus time measured at the potential of 1.50 V vs. RHE for a typical $\text{Fe}_2\text{O}_3|\text{V}_o|\text{Fe}_x\text{S}$.

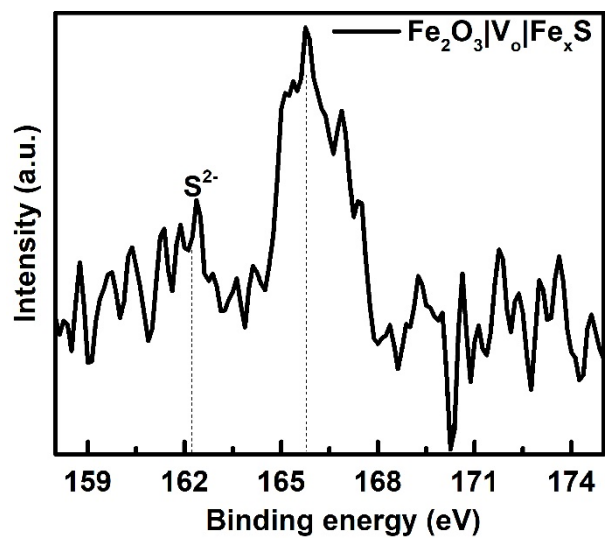


Fig. S7 XPS high resolution S 2p spectra of $\text{Fe}_2\text{O}_3|\text{V}_0|\text{Fe}_x\text{S}$ after the stability test.

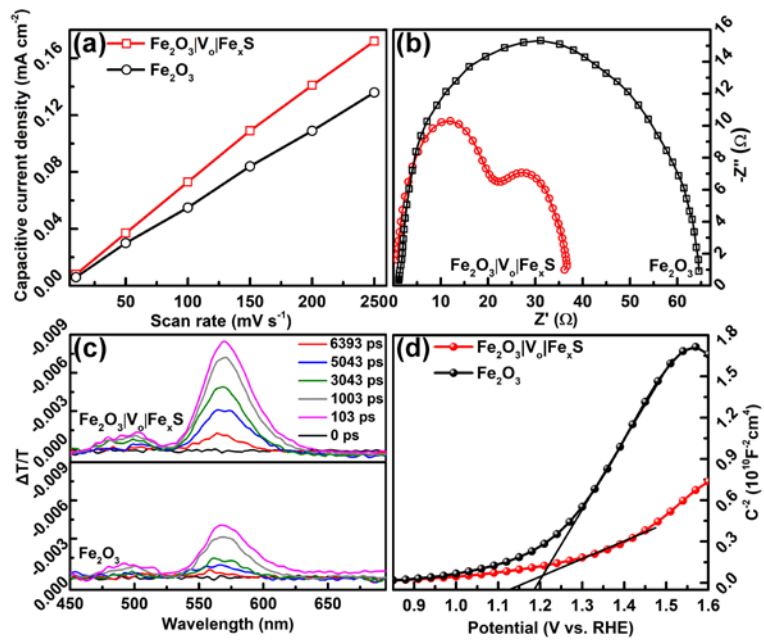


Fig. S8 (a) Plot of scan rate against the difference in the double layer charging current at 1.23 V vs. RHE, (b) EIS spectra, (c) Transient absorption spectra excited by UV laser pulses (350 nm), and (d) Mott-Schottky plots collected at 1 kHz in the dark of Fe_2O_3 and $\text{Fe}_2\text{O}_3|\text{V}_0|\text{Fe}_x\text{S}$, respectively.

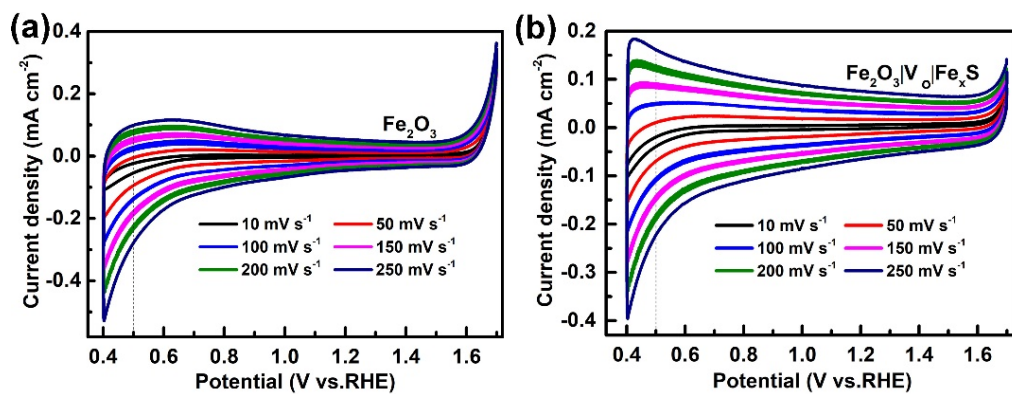


Fig. S9 (a) and (b) Cyclic voltammograms curves of Fe₂O₃ and Fe₂O₃|V_o|Fe_xS at the scan rate from 10 to 250 mV s⁻¹.

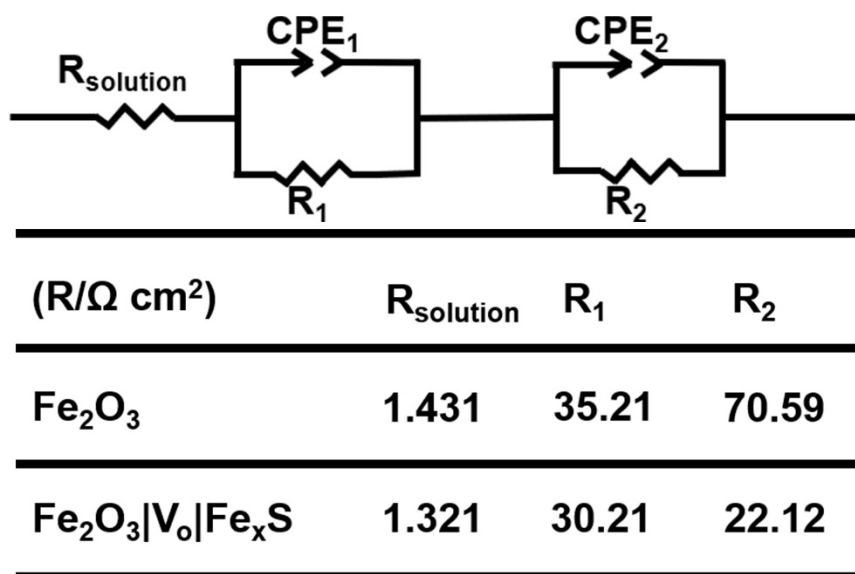


Fig. S10 The equivalent circuit model for data fitting of Figure S8b, as well as the fitting results.

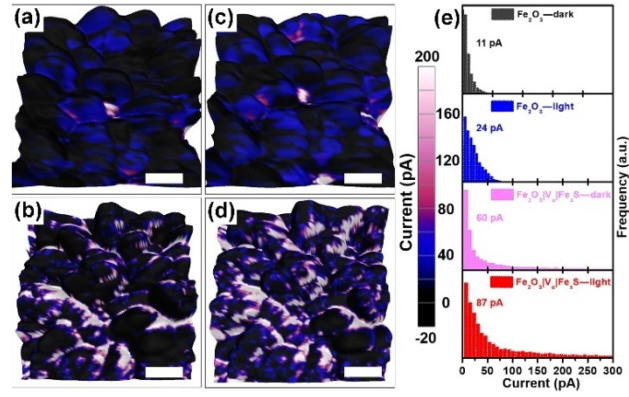


Fig. S11 (a-d) Current images of Fe₂O₃ (a, c) and Fe₂O₃|V₀|Fe_xS (b, d) electrodes collected under dark (a, b) and under illumination (c, d) conditions, mapped by C-AFM at a +1 V sample bias. Scale bars in a-d, 200 nm. The current bar (from -20 pA to 200 pA) is applicable to a-d. (e) Histograms of the current distributions on Fe₂O₃ and Fe₂O₃|V₀|Fe_xS electrodes under dark and illumination conditions and at a +1 V sample bias. The means of the current (11, 24, 60 and 87 pA) are marked in the figure. The illumination condition is created by the 450-nm laser with light intensity of 4 mW/cm².

Table S1. Comparison of previously reported photocurrent density of Fe₂O₃ electrode with our result at 1.5 V vs. RHE

Composite	J _{photo} at 1.5 V (mA/cm ²)	Electrolyte	Scan rate (mV/s)	Synthesis methods	Ref.
FeOOH/Fe ₂ O ₃	1.6	1 M NaOH	10	Precipitation method	(1)
C/Co ₃ O ₄ /Fe ₂ O ₃	2.0	1 M NaOH	—	Hydrothermal approach	(2)
Co ₃ O ₄ /Fe ₂ O ₃	1.75	1 M NaOH	—	In situ hydrothermal	(3)
Co(OH) ₂ /Co ₃ O ₄ /Fe ₂ O ₃	2.0	0.1 M KOH	20	ALD	(4)
Ni(OH) ₂ /IrO ₂ /Fe ₂ O ₃	2.0	1 M NaOH	—	Successive ion layer adsorption (SILA) method	(5)
NiOOH/Fe ₂ O ₃	2.1	1 M NaOH	20	Photoassisted electrodeposition	(6)
FeOOH/Fe ₂ O ₃	1.6	1 M NaOH	—	Solution-based precipitation	(7)
Ni(OH) ₂ /Fe ₂ O ₃	0.55	1 M NaOH	20	Hydrothermal method	(8)
NiFeO _x /Al ₂ O ₃ /Fe ₂ O ₃	3.3	1 M NaOH	10	Photoelectrochemical	(9)
NiBi/Fe ₂ O ₃	0.9	1 M KOH	50	Photochemical deposition	(10)
Ni(OH) ₂ /Fe ₂ O ₃	2.0	1 M NaOH	50	Dipping method	(11)
NiFeO _x /Fe ₂ O ₃	0.67	1 M NaOH	—	Drop-casting	(12)
NiO _x /Fe ₂ O ₃	0.8	1 M NaOH	10	Photodeposited	(13)
Ti-FeOOH/Fe ₂ O ₃	4.10	1 M NaOH	20	Hydrothermal deposition	(14)
Fe ₂ O ₃ Vo Fe ₃ S	4.25	1 M NaOH	10	CVD	This work
Co ₃ O ₄ /Fe ₂ O ₃	0.66	1 M NaOH	10	Plasma-assisted route	(15)

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